



Power MOSFETS

DATASHEET

LM80025NHM8A

N-Channel
Enhancement Mode MOSFET



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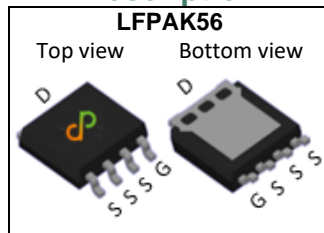


Quality Management Systems

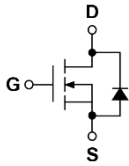
ISO 9001:2015 Certificate

N-Channel Enhancement Mode MOSFET

Pin Description



Symbol



Product Summary

Symbol	N-Channel	Unit
V_{DS}	80	V
$R_{DS(ON)-Max}$	2.5	mΩ
I_D	200	A

Feature

- Fast switching speed
- Reliable and Rugged
- ROHS Compliant & Halogen-Free
- 100% UIS and Rg Tested
- Moisture Sensitivity Level MSL1

Applications

- DC-to-DC converters
- Switch mode power supply
- Brushless DC motor control

Ordering Information

Orderable Part Number	Package Type	Form	Shipping	Marking
LM80025NHM8A	LFPAK56	Tape & Reel	4000 / Tape & Reel	80025 □□□□□□

Note : □□□□□□ = Lot Code

Absolute Maximum Ratings (T_J=25°C Unless Otherwise Noted)

Symbol	Parameter	N-Channel	Unit
V_{DS}	Drain-Source Voltage	80	V
V_{GS}	Gate-Source Voltage	±20	V
T_J	Maximum Junction Temperature	175	°C
T_{STG}	Storage Temperature Range	-55 to 175	°C
I_S	Diode Continuous Forward Current	$T_C=25^\circ\text{C}$ 95	A
I_{SP}	Diode Pulse Current	$T_C=25^\circ\text{C}$ 400	A
I_{DM}	Pulse Drain Current Tested	$T_C=25^\circ\text{C}$ 499 ^①	A
I_D	Continuous Drain Current	$T_C=25^\circ\text{C}$ 200 $T_C=100^\circ\text{C}$ 142	A
P_D	Maximum Power Dissipation	$T_C=25^\circ\text{C}$ 188 $T_C=100^\circ\text{C}$ 94	W
I_D	Continuous Drain Current	$T_A=25^\circ\text{C}$ 30.2 $T_A=70^\circ\text{C}$ 25.3	A
P_D	Maximum Power Dissipation	$T_A=25^\circ\text{C}$ 4.3 $T_A=70^\circ\text{C}$ 3.0	W
$I_{AS}^{②}$	Avalanche Current, Single pulse	$L=0.1\text{mH}$ 57 $L=0.5\text{mH}$ 32	A
$E_{AS}^{②}$	Avalanche Energy, Single pulse	$L=0.1\text{mH}$ 162 $L=0.5\text{mH}$ 256	mJ

2

Thermal Characteristics

Symbol	Parameter	Rating	Unit
$R_{\theta JC}$	Thermal Resistance-Junction to Case	Steady State	0.8
$R_{\theta JA}^{③}$	Thermal Resistance-Junction to Ambient	Steady State	35

Note ① : Max. current is limited by junction temperature

Note ② : UIS tested and pulse width are limited by maximum junction temperature 175°C

Note ③ : Surface Mounted on 1in² FR-4 board with 1oz

N-Channel Electrical Characteristics ($T_J=25^{\circ}\text{C}$ Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Static Electrical Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =250uA	80	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =64V, V _{GS} =0V	-	-	1	uA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250uA	2.3	3	3.7	V
I _{GSS}	Gate Leakage Current	V _{GS} =±20V, V _{DS} =0V	-	-	±100	nA
R _{DS(ON)} ④	Drain-Source On-state Resistance	V _{GS} =10V, I _{DS} =20A	-	2.0	2.5	mΩ
		V _{GS} =6V, I _{DS} =10A		3.3	4.3	
gfs	Forward Transconductance	V _{DS} =5V, I _{DS} =10A	-	29	-	S
Dynamic Characteristics ⑥						
R _G	Gate Resistance	V _{GS} =0V, V _{DS} =0V, Freq.=1MHz	-	0.8	-	Ω
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =40V, Freq.=1MHz	-	5103	-	pF
C _{oss}	Output Capacitance		-	1695	-	
C _{rss}	Reverse Transfer Capacitance		-	97	-	
td(ON)	Turn-on Delay Time	V _{GS} =10V, V _{DS} =40V, I _D =1A, R _{GEN} =1Ω	-	20	-	nS
tr	Turn-on Rise Time		-	12	-	
td(OFF)	Turn-off Delay Time		-	51	-	
tf	Turn-off Fall Time		-	94	-	
Qg	Total Gate Charge	V _{GS} =10V, V _{DS} =40V, I _D =20A	-	82	-	nC
Qgs	Gate-Source Charge		-	22	-	
Qgd	Gate-Drain Charge		-	22	-	
Source-Drain Characteristics						
VSD④	Diode Forward Voltage	ISD=10A, VGS=0V	-	0.75	1.1	V
trr	Reverse Recovery Time	IF=10A, VR=40V	-	86	-	nS
Qrr	Reverse Recovery Charge	dIF/dt=100A/μs	-	84	-	nC

Note ④ : Pulse test (pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$).

Note ⑤ : Guaranteed by design, not subject to production testing.

N-Channel Typical Characteristics

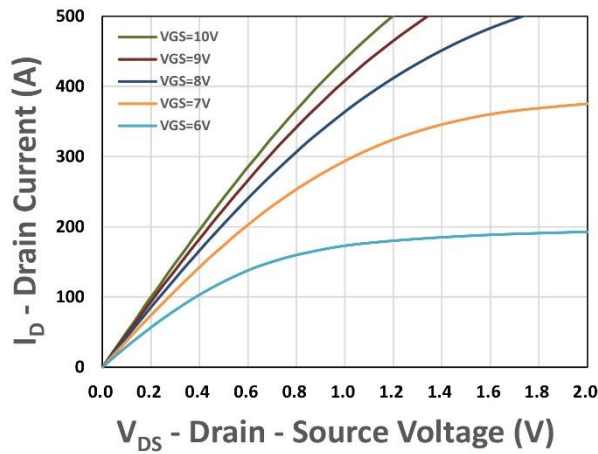


Figure 1. Output Characteristics

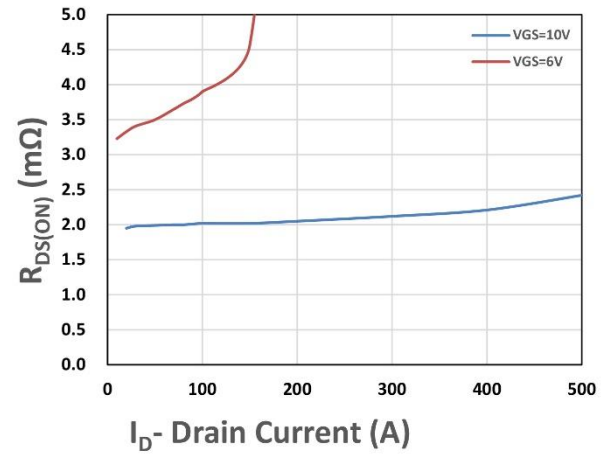


Figure 2. On-Resistance vs. I_D

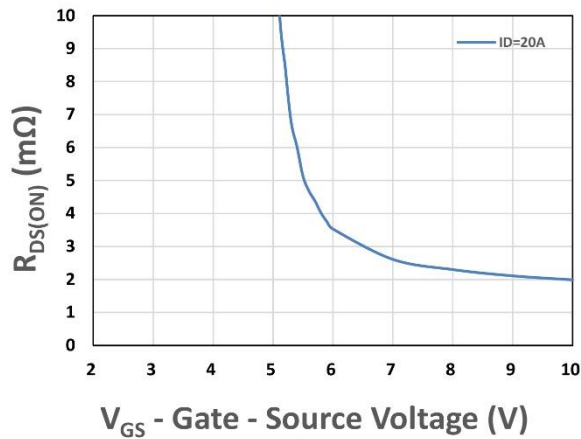


Figure 3. On-Resistance vs. V_{GS}

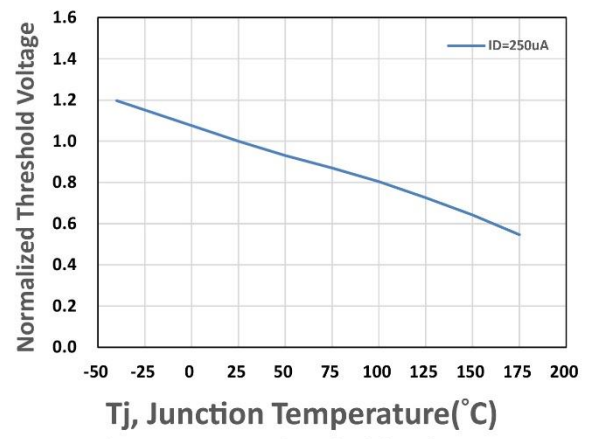


Figure 4. Gate Threshold Voltage

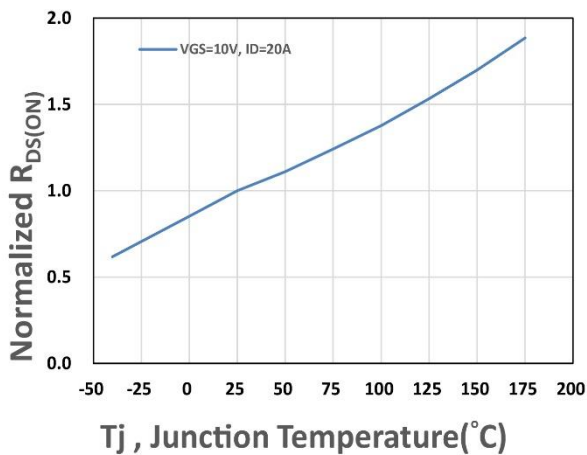


Figure 5. Drain-Source On Resistance

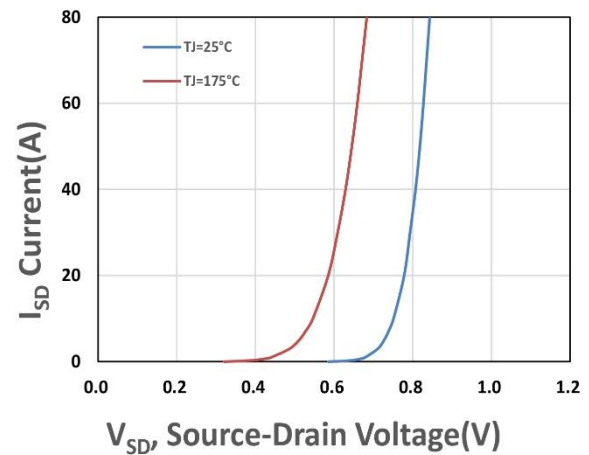


Figure 6. Source-Drain Diode Forward

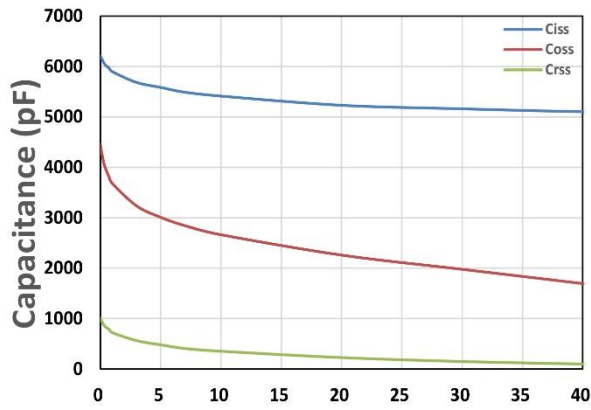


Figure 7. Capacitance

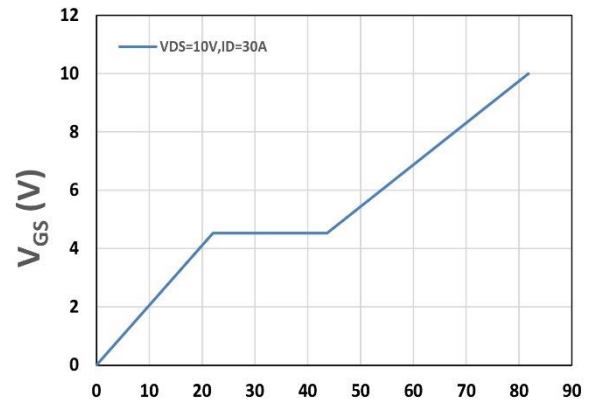


Figure 8. Gate Charge Characteristics

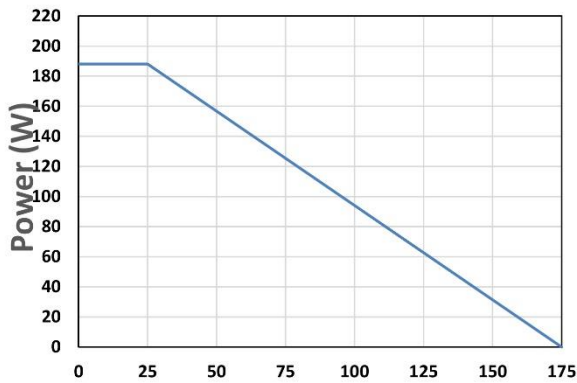


Figure 9. Power Dissipation

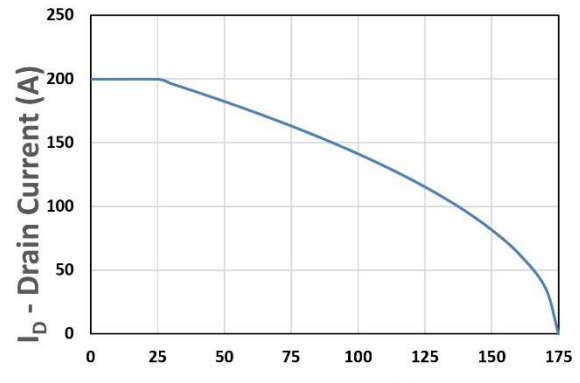


Figure 10. Drain Current

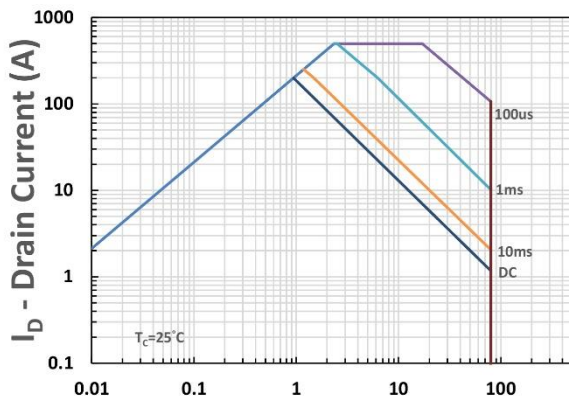


Figure 11. Safe Operating Area

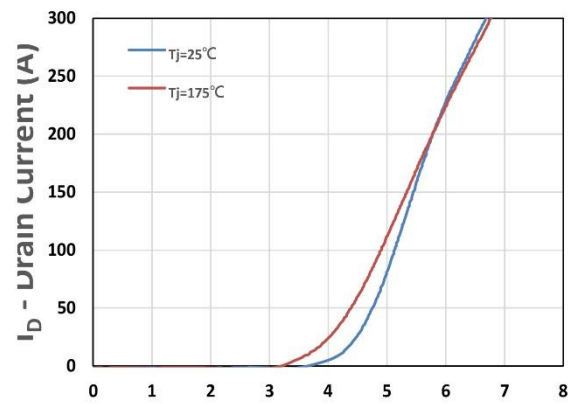


Figure 12. Transfer Characteristics

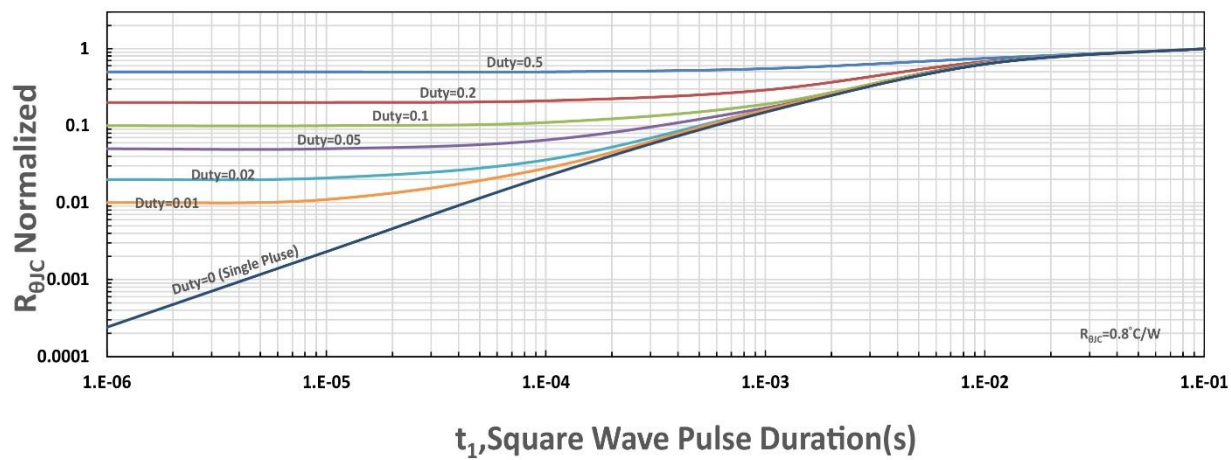


Figure 13. $R_{\theta JC}$ Transient Thermal Impedance